

Quarterly Reliability Monitoring Results

Quarters: Q1/2022 to Q4/2023

Based on structural similarity

Supplier Nexperia B.V.		User Part Number						
		PESD30VF1BSF						
Name of Laboratory		Part Description						
		Nexperia DHAM	Protection Std	l Bipolar				
Assembly reliability labs		BD package						
Test		Test Conditions	Duration	# Lots	# Quantity	# Rejects		
	TEST							
	Pre- and Post-Stress							
# 1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below		
		MIL-STD-750-1						
	HTRB	M1038 Method A						
	•	Tj = Tjmax, Vr = 100% of max. datasheet						
# 5	Bias	reverse voltage	1000 hours	17	760	0		
	TC	JESD22-A104						
# 7	Temperature Cycling	-40 °C to 125°C	1000 cycles	157	6880	0		
	UHAST	JESD22-A118						
# 8 o r	Unbiased HAST	Tamb = 130 °C, RH = 85 %						
# 0 01	Olibiased HAST		- 96 hours	n.a.	n.a.	n.a.		
		JESD22-A102						
	AC	Tamb = 121 °C, RH = 100 %						
# 8a	Autoclave	Pressure = 205 kPa (29.7 psia)						
	HAST	JESD22-A110						
	Highly Accelerated Stress	Tamb = 130 °C, RH = 85%, VR = 80 % of						
# 9	Test	rated reverse voltage ^[1]	1000 hours	156	6840	0		
# 9	1630		1000 110015	130	0040	U		
	IOL	MIL-STD-750 Method 1037 ton = toff, devices powered to insure ΔT_j =						
" 10	Intermittent Operating Life		10001					
# 10	Intermittent Operating Life	100 °C 101 13000 cycles	1000 hours	n.a.	n.a.	n.a.		
	RSH	JESD22-A111						
# 20	Resistance to Solder Heat	260 °C ± 5 °C	10 s	n.a.	n.a.	n.a.		
" ZU	SD SD		103	mu.	11.0.	ma.		
# 21	Solderability	J-STD-002		8	240	0		

^[1] The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

Calculation of FIT and MTTF

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test # 5) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Wafer Fab	Technology	Quantity	Rejects	Failure Rate (FIT)	MTTF (hrs)
Nexperia					
DHAM	Protection Std Bipolar	760	0	5,59	1,79E+08

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